Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/530,129	VERSCHUEREN, ERIC	
Examiner	Art Unit	
John S. Chu	1752	

SEARCHED						
Class	Subclass	Date	Examiner			
430	270.1	1/2007	281			
430	302	1 4				
101	463.1					
427	374.1					
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
		DATE	EXMR	
EAST SEARCH IN FILE		7/2017	Jse	
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